Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,258	MIYANO ET AL.	
Examiner	Art Unit	
B. Chen	1762	

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Class	Subclass	Date	Examiner
updated	previous	10/1/2006	вс
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SE. (INCLUDING	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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east .		10/1/2006	ВС		